

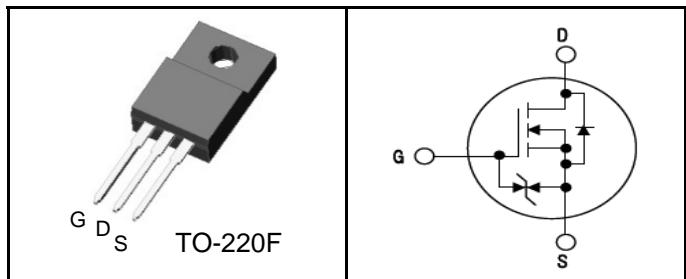
## 650V N-Channel Super Junction MOSFET

### Features

- $V_{DSS}=650\text{ V}$ ,  $I_D=6.7\text{ A}$
- $R_{DS(on)}:0.64\Omega\text{ (Max) } @ V_{GS}=10\text{V}$
- Very Low FOM ( $R_{DS(on)} \times Q_g$ )
- Extremely low switching loss
- Excellent stability and uniformity
- 100% Avalanche Tested
- Built-in ESD Diode

### Application

- Switch Mode Power Supply (SMPS)
- Power Factor Correction (PFC)
- TV power & LED Lighting Power
- AC to DC Converters
- Telecom



### Device Marking and Package Information

Ordering Code	Package	Marking
MPSA65M640B	TO-220F	MP65M640B

### Absolute Maximum Ratings

$T_c=25^\circ\text{C}$  unless otherwise specified

Symbol	Parameter	Value	Unit
$V_{DSS}$	Drain-Source Voltage	650	V
$V_{GS}$	Gate-Source Voltage	$\pm 20$	V
$I_D$	Drain Current - Continuous ( $T_c = 25^\circ\text{C}$ )	6.7 *	A
	Drain Current - Continuous ( $T_c = 100^\circ\text{C}$ )	4.2 *	A
$I_{DM}^1)$	Drain Current - Pulsed	20 *	A
$E_{AS}^2)$	Single Pulsed Avalanche Energy	73	mJ
$I_{AR}$	Avalanche Current	1.3	A
$dv/dt$	MOSFET $dv/dt$ ruggedness, $V_{DS}=0\ldots 400\text{V}$	50	V/ns
$dv/dt$	Reverse diode $dv/dt$ , $V_{DS}=0\ldots 400\text{V}$ , $I_{DS} \leq I_D$	15	V/ns
$P_D$	Power Dissipation ( $T_c = 25^\circ\text{C}$ )	27	W
$V_{ESD(G-S)}$	Gate source ESD(HBM-C=100pF, $R=1.5\text{K}\Omega$ )	2000	V
$T_J, T_{STG}$	Operating and Storage Temperature Range	-55 to +150	°C

\* Drain current limited by maximum junction temperature

### Thermal Resistance Characteristics

Symbol	Parameter	Value	Unit
$R_{\theta JC}$	Thermal Resistance, Junction-to-Case, Max.	4.61	°C/W
$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient , Max.	80	°C/W



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MPSA65M640B

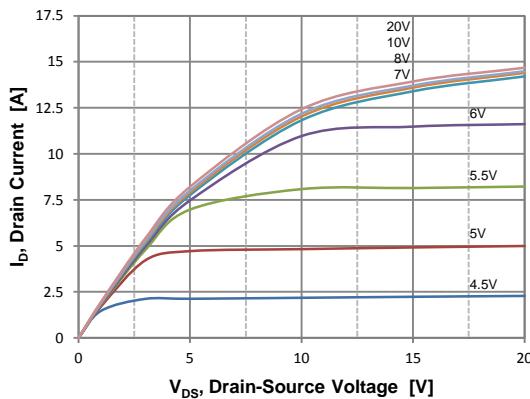
**Electrical Characteristics**  $T_J=25^\circ\text{C}$  unless otherwise specified

Symbol	Parameter	Test Conditions	Min	Typ	Max	Unit
<b>On Characteristics</b>						
$V_{GS}$	Gate Threshold Voltage	$V_{DS} = V_{GS}$ , $I_D = 220 \mu\text{A}$	2.0	-	4.0	V
$R_{DS(\text{ON})}$	Static Drain-Source On-Resistance	$V_{GS} = 10 \text{ V}$ , $I_D = 2.0 \text{ A}$	-	0.555	0.64	$\Omega$
<b>Off Characteristics</b>						
$BV_{DSS}$	Drain-Source Breakdown Voltage	$V_{GS} = 0 \text{ V}$ , $I_D = 1\text{mA}$	650	-	-	V
$I_{DSS}$	Zero Gate Voltage Drain Current	$V_{DS} = 650 \text{ V}$ , $V_{GS} = 0$	-	-	1	$\mu\text{A}$
		$V_{DS} = 650 \text{ V}$ , $T_C = 150^\circ\text{C}$	-	-	100	$\mu\text{A}$
$I_{GSS}$	Gate-Body Leakage Current	$V_{GS} = \pm 20 \text{ V}$ , $V_{DS} = 0 \text{ V}$	-	-	$\pm 1$	$\mu\text{A}$
<b>Dynamic Characteristics</b>						
$C_{iss}$	Input Capacitance	$V_{DS} = 400 \text{ V}$ , $V_{GS} = 0 \text{ V}$ , $f = 1.0 \text{ MHz}$	-	588	-	pF
$C_{oss}$	Output Capacitance		-	17	-	pF
$C_{rss}$	Reverse Transfer Capacitance		-	2.7	-	pF
<b>Switching Characteristics</b>						
$t_{d(on)}$	Turn-On Time	$V_{DS} = 325 \text{ V}$ , $I_D = 2.9 \text{ A}$ , $R_G = 25 \Omega$ (Note 3,4)	-	23	-	ns
$t_r$	Turn-On Rise Time		-	18	-	ns
$t_{d(off)}$	Turn-Off Delay Time		-	77	-	ns
$t_f$	Turn-Off Fall Time		-	18	-	ns
$Q_g$	Total Gate Charge	$V_{DS} = 520 \text{ V}$ , $I_D = 2.9 \text{ A}$ , $V_{GS} = 10 \text{ V}$ (Note 3,4)	-	14	-	nC
$Q_{gs}$	Gate-Source Charge		-	2.6	-	nC
$Q_{gd}$	Gate-Drain Charge		-	4.5	-	nC
<b>Drain-Source Diode Characteristics and Maximum Ratings</b>						
$I_S$	Maximum Continuous Drain-Source Diode Forward Current	-	-	6.7	A	
$I_{SM}$	Maximum Pulsed Drain-Source Diode Forward Current	-	-	20	A	
$V_{SD}$	Drain-Source Diode Forward Voltage	$V_{GS} = 0 \text{ V}$ , $I_S = 2.9 \text{ A}$	-	-	1.3	V
$trr$	Reverse Recovery Time	$V_R = 400 \text{ V}$ , $I_F = 2.9 \text{ A}$ $dI_F/dt = 100 \text{ A}/\mu\text{s}$	-	250	-	ns
$Qrr$	Reverse Recovery Charge		-	1.8	-	$\mu\text{C}$

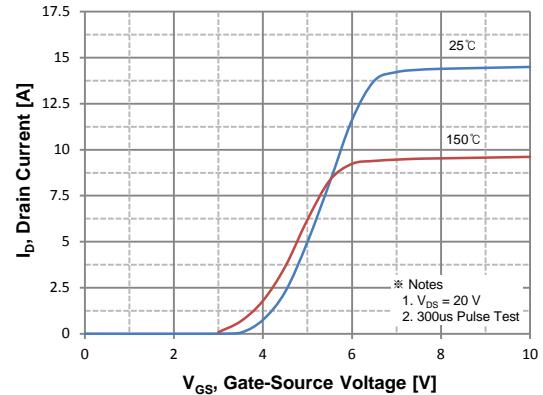
**Notes :**

- Repetitive Rating : Pulse width limited by maximum junction temperature
- $I_{AS}=1.3\text{A}$   $V_{DD}=50\text{V}$ ,  $R_G=25\Omega$ , Starting  $T_J=25^\circ\text{C}$
- Pulse Test : Pulse Width  $\leq 300\mu\text{s}$ , Duty Cycle  $\leq 2\%$
- Essentially Independent of Operating Temperature

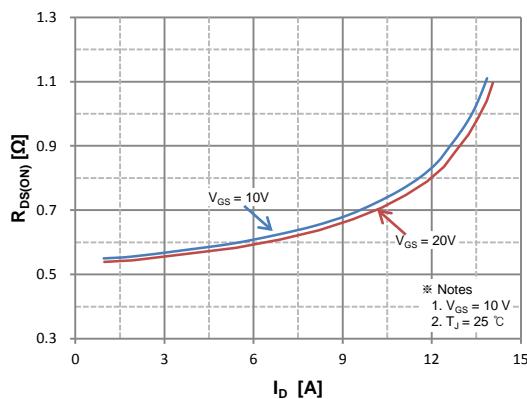
## Typical Characteristics



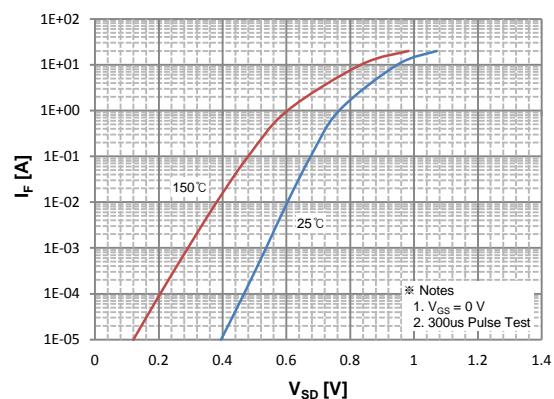
**Figure 1. On Region Characteristics**



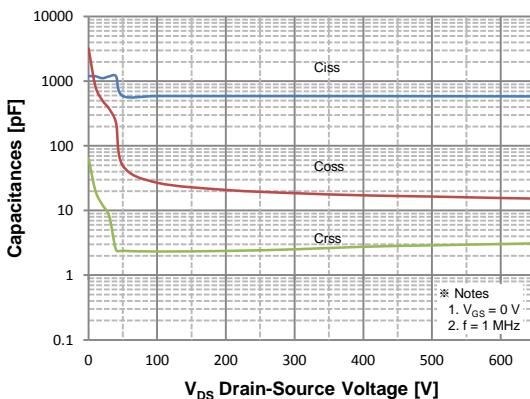
**Figure 2. Transfer Characteristics**



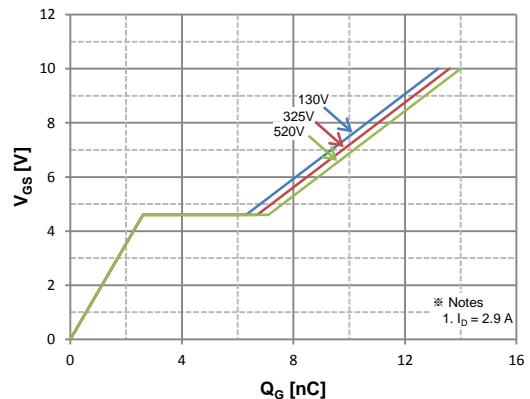
**Figure 3. On Resistance Variation vs Drain Current and Gate Voltage**



**Figure 4. Body Diode Forward Voltage Variation with Source Current and Temperature**

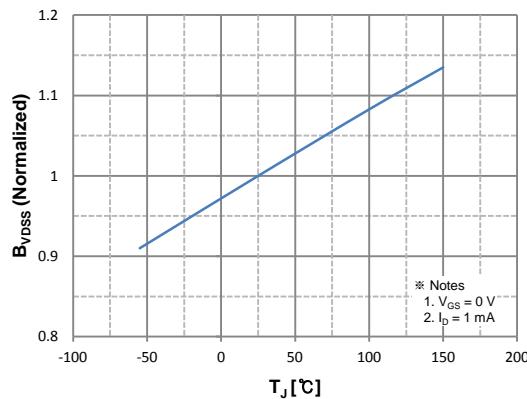


**Figure 5. Capacitance Characteristics**

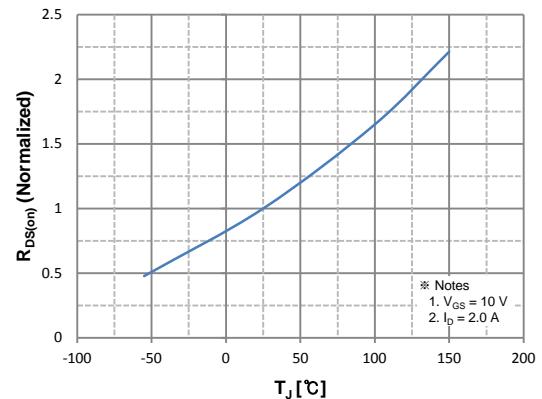


**Figure 6. Gate Charge Characteristics**

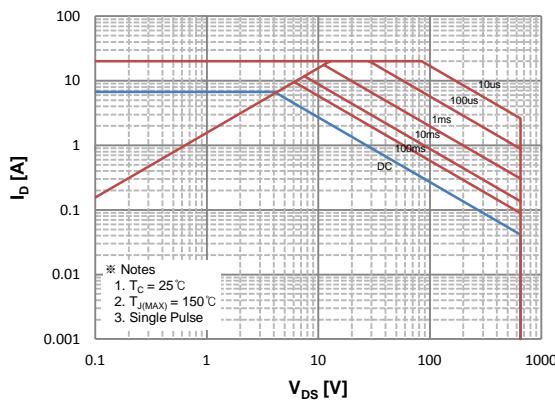
## Typical Characteristics



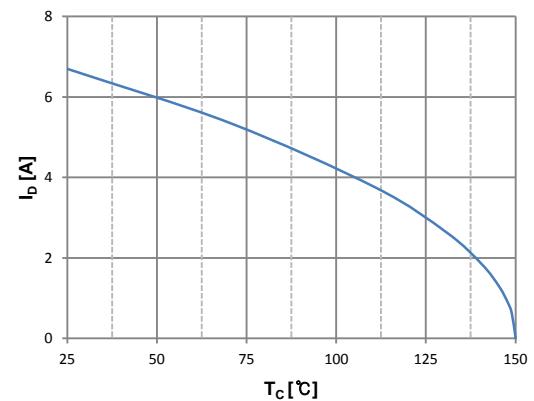
**Figure 7. Breakdown Voltage Variation  
vs. Temperature**



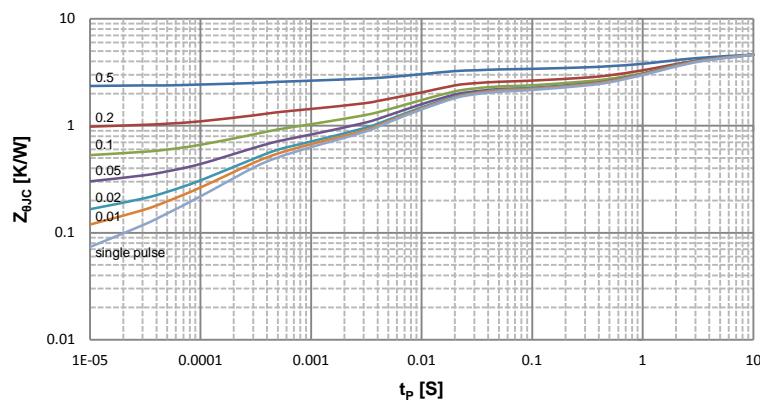
**Figure 8. On-Resistance Variation  
vs. Temperature**



**Figure 9. Maximum Safe Operating Area**



**Figure 10. Maximum Drain Current  
vs. Case Temperature**



**Figure 11. Transient Thermal Response Curve**

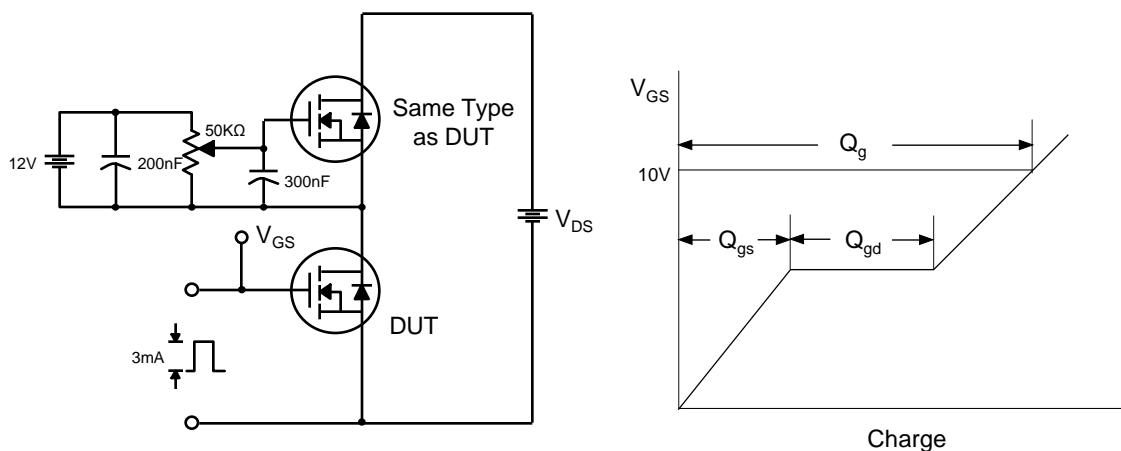
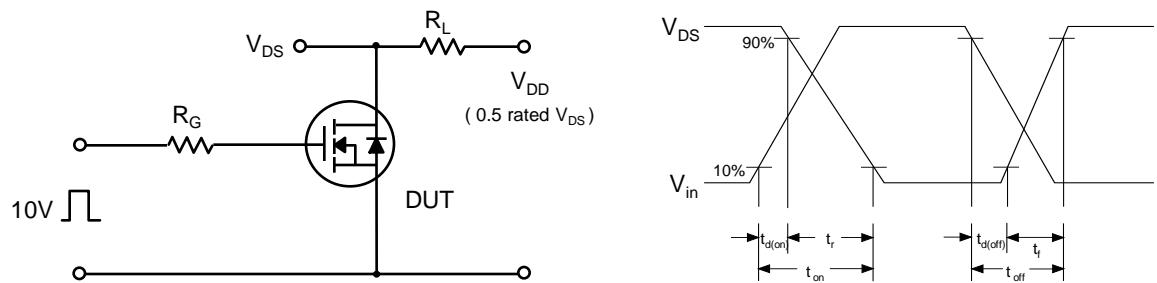
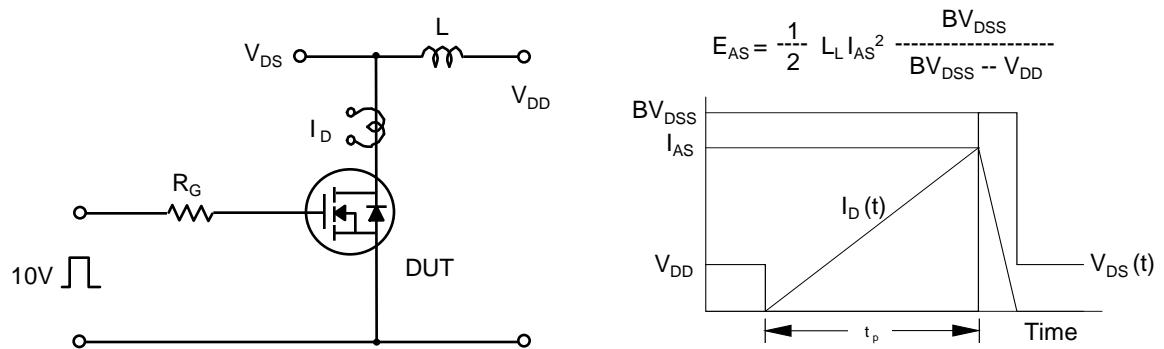
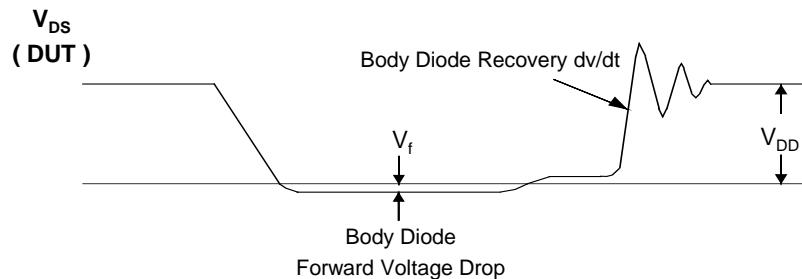
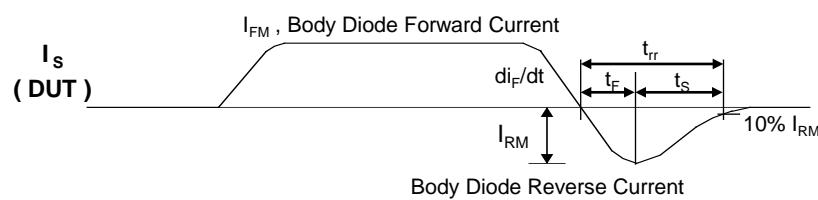
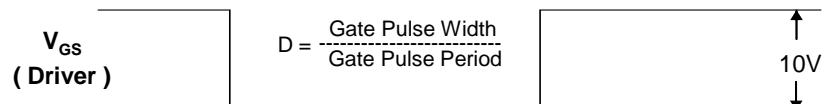
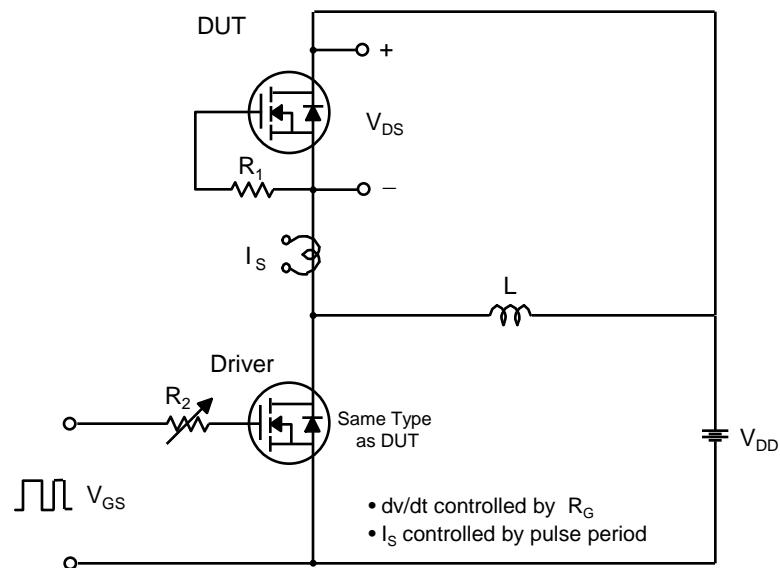
**Fig 12. Gate Charge Test Circuit & Waveform**

**Fig 13. Resistive Switching Test Circuit & Waveforms**

**Fig 14. Unclamped Inductive Switching Test Circuit & Waveforms**


Fig 15. Peak Diode Recovery dv/dt Test Circuit &amp; Waveforms

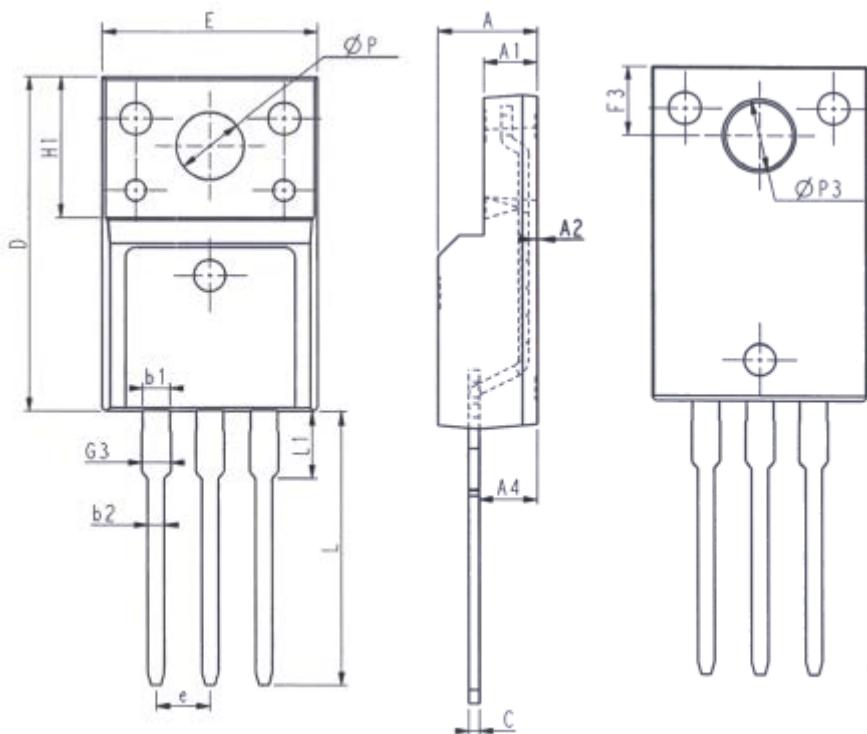




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# MPSA65M640B

TO-220F



Unit: mm		
Symbol	Min.	Max.
E	9.96	10.36
A	4.50	4.90
A1	2.34	2.74
A2	0.30	0.60
A4	2.56	2.96
c	0.40	0.65
D	15.57	16.17
H1	6.70REF	
e	2.54BSC	

Unit: mm		
Symbol	Min.	Max.
L	12. 68	13. 28
L1	2. 93	3. 13
P	3. 03	3. 38
P3	3. 15	3. 65
F3	3. 15	3. 45
G3	1. 25	1. 55
b1	1. 18	1. 43
b2	0. 70	0. 95